



REPORT No.: SZ21100063E01

TEST REPORT

APPLICANT : SEUIC Technologies Co., Ltd.

PRODUCT NAME : Handheld RFID Reader

MODEL NAME : AUTOID UTouch

BRAND NAME : Seuic

FCC ID : 2AC68-AUTOIDUTOUCH

STANDARD(S) : 47 CFR Part 15 Subpart B

RECEIPT DATE : 2021-10-27

TEST DATE : 2021-11-10 to 2021-11-15

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MORLAB

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DIRECTORY

1. Technical Information.....	3
1.1. Applicant and Manufacturer Information.....	3
1.2. Equipment Under Test (EUT) Description	3
2. Test Results	6
2.1. Applied Reference Documents	6
2.2. EUT Setup and Operating Conditions.....	7
3. 47 CFR Part 15B Requirements	8
3.1. Conducted Emission	8
3.2. Radiated Emission	12
Annex A Test Uncertainty	19
Annex B Testing Laboratory Information	20

Change History		
Version	Date	Reason for change
1.0	2021-12-21	First edition



1. Technical Information

Note: Provide by applicant.

1.1. Applicant and Manufacturer Information

Applicant:	SEUIC Technologies Co., Ltd.
Applicant Address:	NO.15 Xinghuo Road, Nanjing New & High Technology Industry Development Zone, 210061, Nanjing City, Jiangsu Province, China
Manufacturer:	SEUIC Technologies Co., Ltd.
Manufacturer Address:	NO.15 Xinghuo Road, Nanjing New & High Technology Industry Development Zone, 210061, Nanjing City, Jiangsu Province, China

1.2. Equipment Under Test (EUT) Description

Product Name:	Handheld RFID Reader
EUT No.:	1#
Hardware Version:	SLB761XC-64B_MB_PCBA_V1.00
Software Version:	V0.2.6.1
Tx Frequency:	GSM850: 824 MHz ~ 849 MHz GSM1900: 1850 MHz ~ 1910 MHz CDMA 2000 BC 0: 824 MHz ~ 849 MHz WCDMA Band II: 1850 MHz ~ 1910 MHz WCDMA Band V: 824 MHz ~ 849 MHz LTE Band 5: 824 MHz ~ 849 MHz LTE Band 7: 2500 MHz ~ 2570 MHz LTE Band 38: 2570 MHz ~ 2620 MHz LTE Band 41: 2555 MHz ~ 2655 MHz 802.11b/g/n: 2412 MHz ~ 2462 MHz 802.11a/ac/n: 5180 MHz ~ 5240 MHz; 5260 MHz ~ 5320 MHz; 5500 MHz ~ 5720 MHz; 5745MHz ~ 5825 MHz Bluetooth: 2402 MHz ~ 2480 MHz NFC:13.56MHz RFID:902.75 MHz ~ 927.25 MHz
Rx Frequency:	GSM850: 869 MHz ~ 894 MHz GSM1900: 1930 MHz ~ 1990 MHz CDMA 2000 BC 0: 869 MHz ~ 894 MHz WCDMA Band II: 1930 MHz ~ 1990 MHz



	WCDMA Band V: 869 MHz ~ 894 MHz LTE Band 5: 869 MHz ~ 894 MHz LTE Band 7: 2620 MHz ~ 2690 MHz LTE Band 38: 2570 MHz ~ 2620 MHz LTE Band 41: 2555 MHz ~ 2655 MHz 802.11b/g/n: 2412 MHz ~ 2462 MHz 802.11a/ac/n: 5180 MHz ~ 5240 MHz; 5260 MHz ~ 5320 MHz; 5500 MHz ~ 5720 MHz; 5745 MHz ~ 5825 MHz Bluetooth: 2402 MHz ~ 2480 MHz GPS/GLONASS/BDS/Galileo: 1559 MHz ~ 1610 MHz NFC: 13.56 MHz RFID: 902.75 MHz ~ 927.25 MHz	
Ancillary Equipment:	Battery 1	
	Brand Name:	N/A
	Model No.:	D500HB-V1(1S2P)
	Serial No.:	(N/A, marked #1 by test site)
	Capacity:	6200mAh
	Rated Voltage:	3.6V
	Charge Limit:	4.2V
	Manufacturer:	Suzhou Xinfeibo Electronic Technology Co., Ltd.
	Battery 2	
	Brand Name:	N/A
	Model No.:	BOB320724
	Serial No.:	(N/A, marked #1 by test site)
	Capacity:	57 mAh
	Rated Voltage:	3.8V
	Charge Limit:	4.35V
	Manufacturer:	DONGGUAN BOB ELECTRONICS CO., LTD
	Adapter 1	
	Brand Name:	Tianyin
	Model No.:	TPA-23A050200UU01
	Serial No.:	(N/A, marked #1 by test site)
	Rated Input:	100-240V~50/60Hz, 0.3A
	Rated Output:	5.0V=2.0A
	Manufacturer:	Shenzhen Tianyin Electronics Co., Ltd
	USB Cable	
	Model No.:	2305018-2



REPORT No.: SZ21100063E01

	Manufacturer:	TE
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Note:

1. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.

2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result	Method determination Remark
1	15.107	Conducted Emission	2021.11.10	Lin Jiayong	PASS	No deviation
2	15.109	Radiated Emission	2021.11.15	Yang Lian	PASS	No deviation

Note 1:The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.

Note 2:Additions to, deviation, or exclusions from the method shall be judged in the "method determination" column of add, deviate or exclude from the specific method shall be explained in the "Remark" of the above table.

Note 3:When the test result is a critical value,we will use the measurement uncertainty give the judgment result based on the 95% confidence intervals.



2.2. EUT Setup and Operating Conditions

Test Item	
Radiated Emission	
Mode 1	: EUT+Adapter+Scan Mode
Mode 2	: EUT+Adapter+ Camera Mode
Mode 3	: EUT+PC+PC Adapter+ Data Transmission Mode
Conducted Emission	
Mode 1	: EUT+Adapter+Scan Mode
Mode 2	: EUT+Adapter+ Camera Mode
Mode 3	: EUT+PC+PC Adapter+ Data Transmission Mode
Remark: The above test mode in boldface (Mode 3) was the worst case of radiated emission test, only the test data of these modes were reported	

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

3. 47 CFR Part 15B Requirements

3.1. Conducted Emission

3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

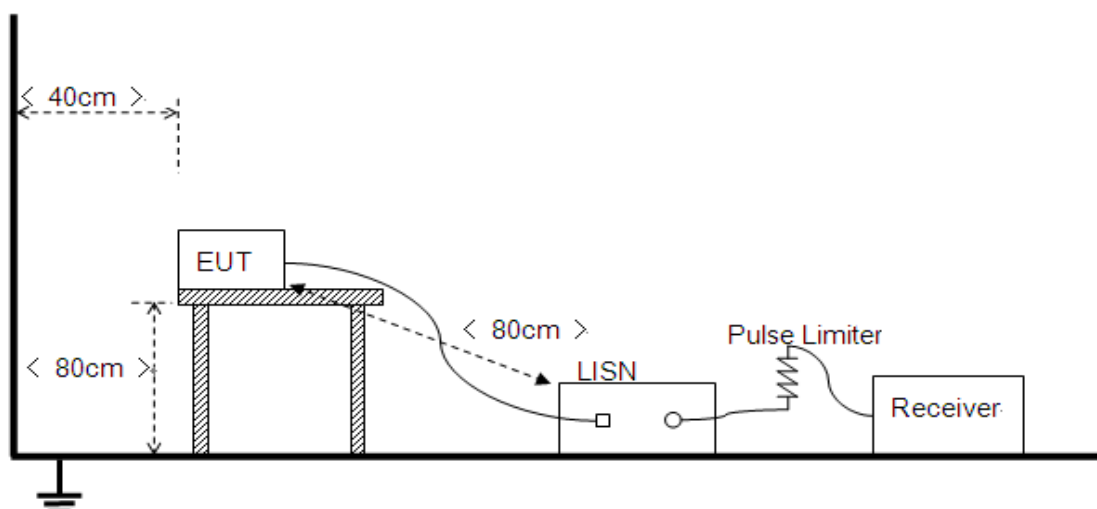
Frequency Range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

Note:

- The limit subjects to the Class B digital device.
- The lower limit shall apply at the band edges.
- The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.





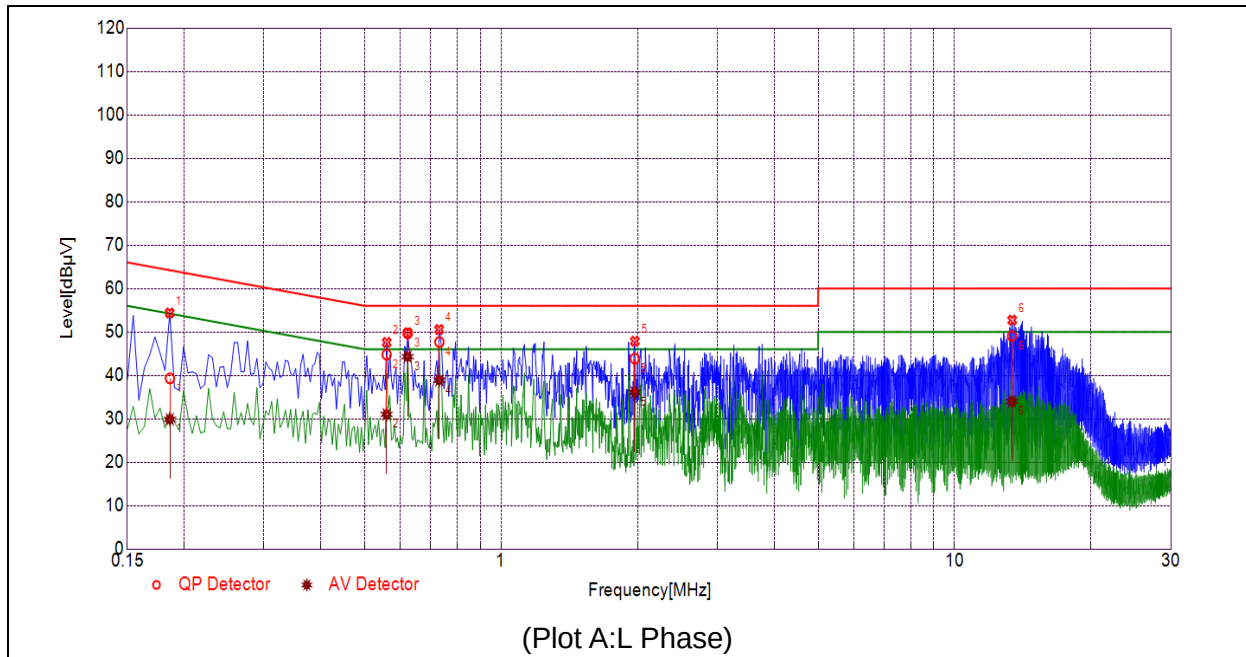
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity is maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

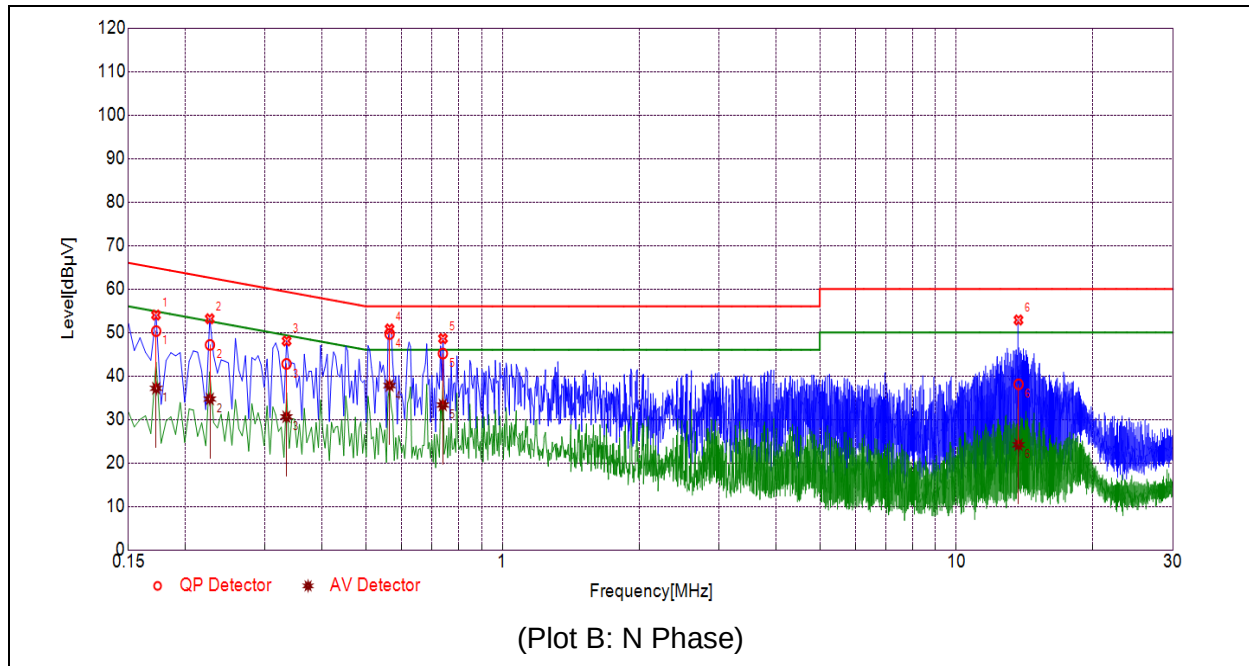
3.1.3. Test Result

Set RBW=9 kHz, VBW=30 kHz. The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



NO.	Fre. (MHz)	Emission Level (dBμV)		Limit (dBμV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.1861	39.29	29.85	64.21	54.21	Line	PASS
2	0.5593	44.78	31.02	56.00	46.00		PASS
3	0.6222	49.65	44.29	56.00	46.00		PASS
4	0.7310	47.67	38.88	56.00	46.00		PASS
5	1.9707	43.85	36.08	56.00	46.00		PASS
6	13.3846	49.05	33.99	60.00	50.00		PASS



NO.	Fre. (MHz)	Emission Level (dBμV)		Limit (dBμV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.1726	50.30	37.15	64.83	54.83	Neutral	PASS
2	0.2267	47.13	34.69	62.57	52.57		PASS
3	0.3343	42.77	30.60	59.34	49.34		PASS
4	0.5640	49.63	37.79	56.00	46.00		PASS
5	0.7389	45.14	33.31	56.00	46.00		PASS
6	13.7062	38.08	24.17	60.00	50.00		PASS



3.2. Radiated Emission

3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency Range (MHz)	Field Strength Limitation at 3m Measurement Dist	
	($\mu\text{V/m}$)	(dB $\mu\text{V/m}$)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dB $\mu\text{V/m}$ is calculated by 20log Emission Level($\mu\text{V/m}$).

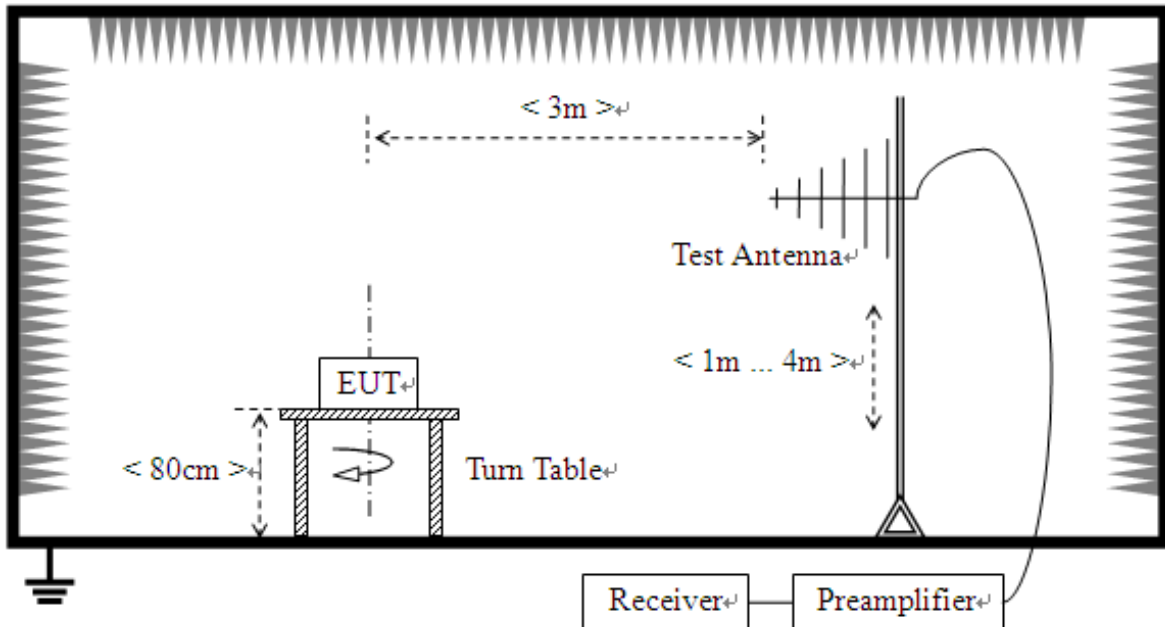
3.2.2. Frequency Range of Measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

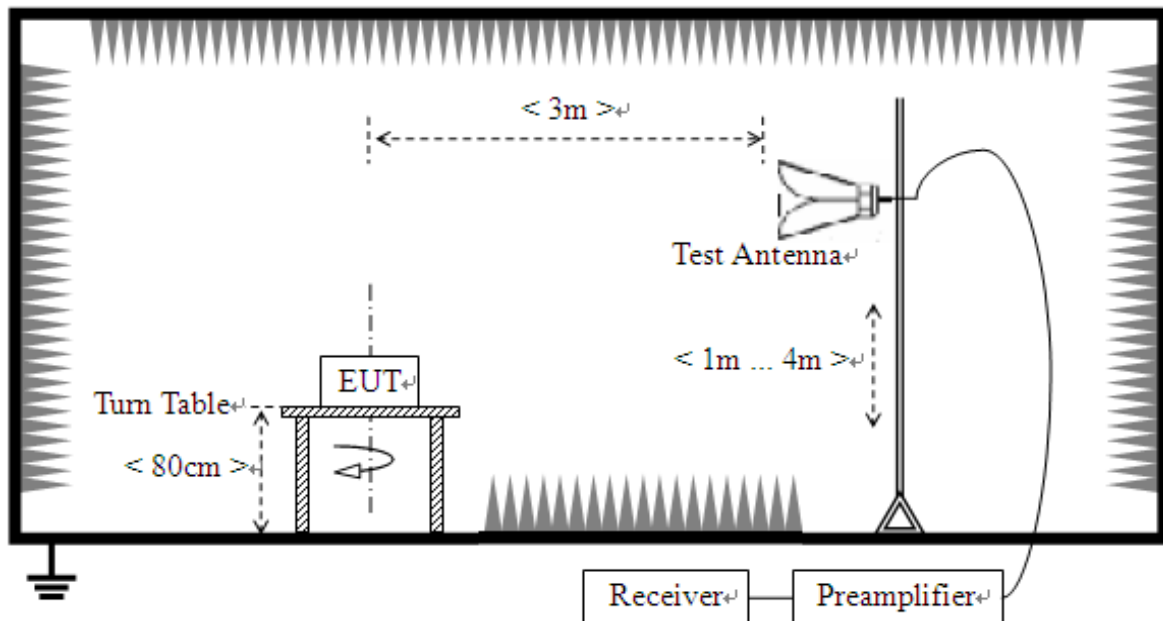
Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30.
1.705-108	1000.
108-500	2000.
500-1000	5000.
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

3.2.3. Test Setup

- 1) For radiated emissions from 30MHz to 1GHz



- 2) For radiated emissions above 1GHz





The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

For measurements below 1GHz the resolution bandwidth is set to 120 kHz for peak detection measurements or 120kHz for quasi-peak detection measurements. Peak detection is used unless otherwise noted as quasi-peak.

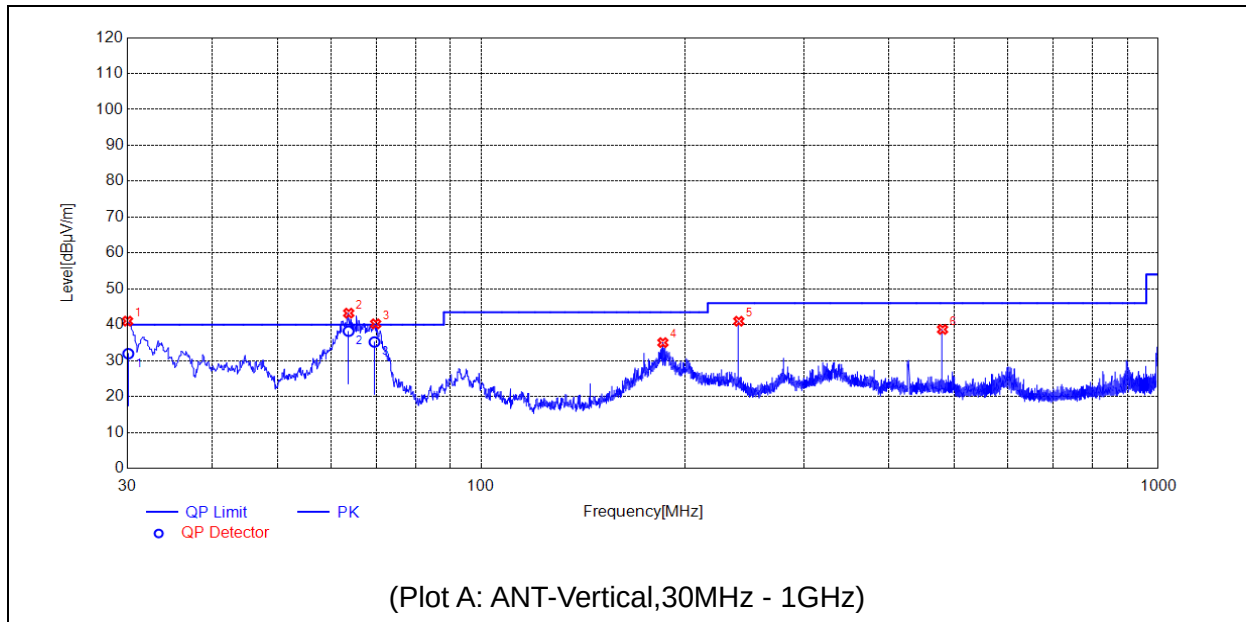
For measurements above 1GHz the resolution bandwidth is set to 1MHz, the video bandwidth is set to 3MHz for peak measurements and as applicable for average measurements.

3.2.4. Test Result

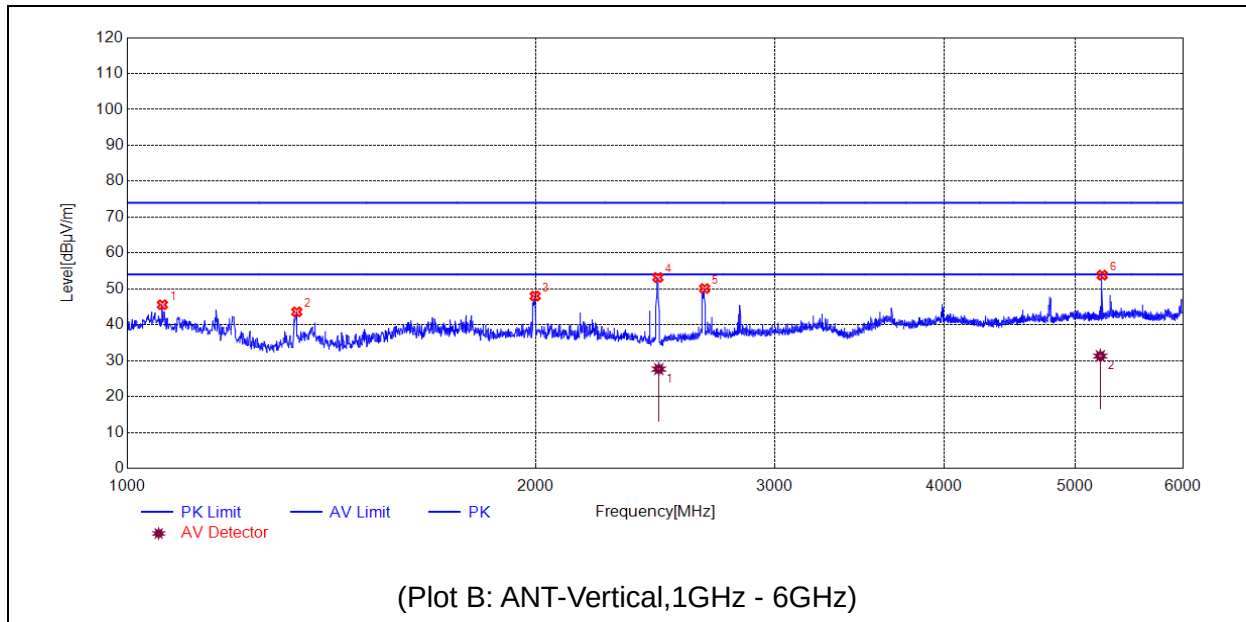
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of emissions (6GHz-30GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

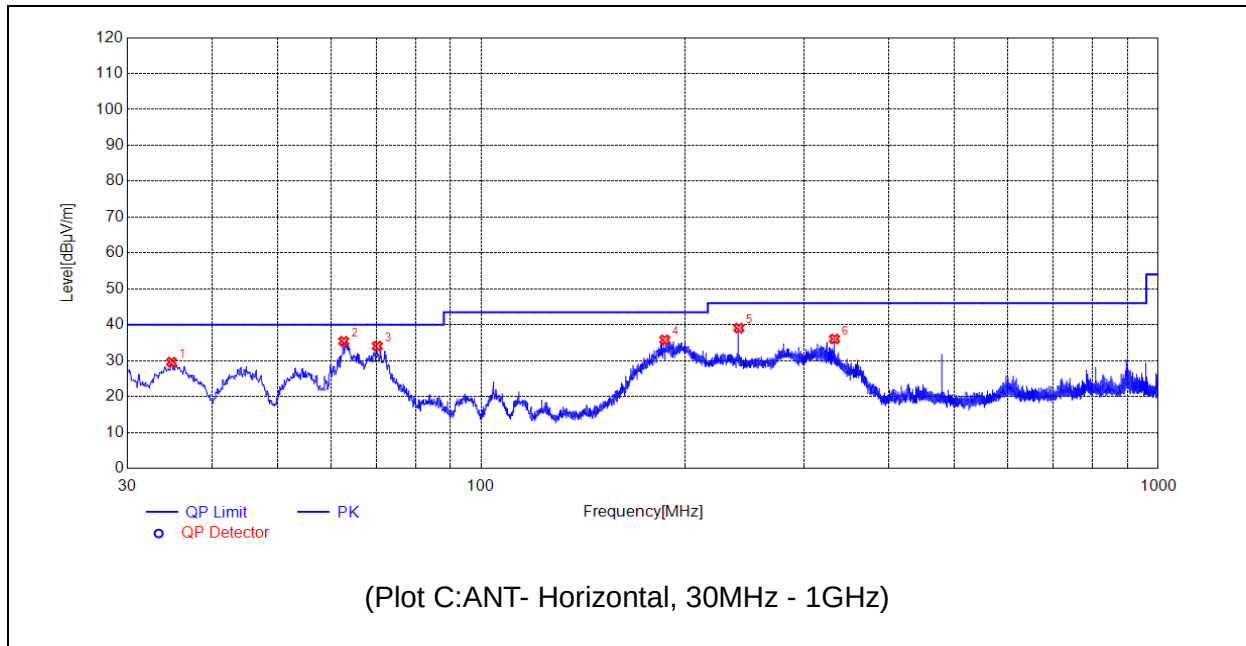
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.



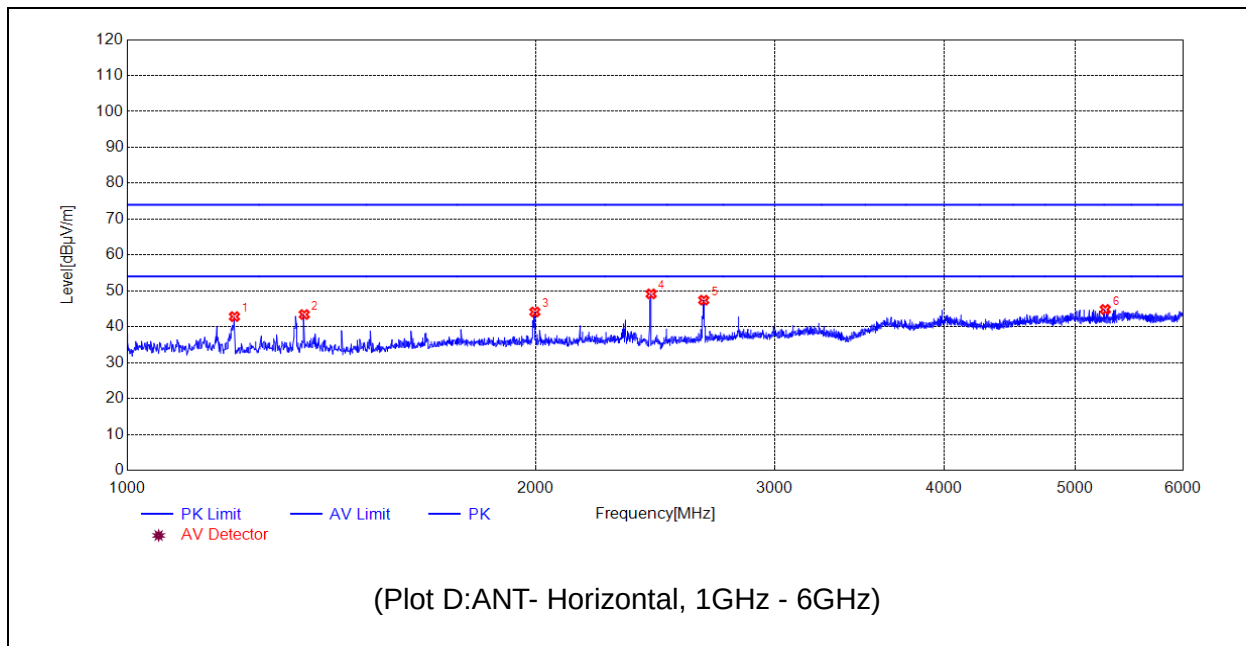
No.	Fre. MHz	PK dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	30.0000	41.01	31.94	N.A.	N.A.	40.00	N.A.	V	PASS
2	63.6624	43.23	38.21	N.A.	N.A.	40.00	N.A.	V	PASS
3	69.7740	40.26	35.20	N.A.	N.A.	40.00	N.A.	V	PASS
4	185.4095	35.02	N.A.	N.A.	N.A.	43.50	N.A.	V	PASS
5	240.0260	40.99	N.A.	N.A.	N.A.	46.00	N.A.	V	PASS
6	480.0280	38.70	N.A.	N.A.	N.A.	46.00	N.A.	V	PASS



No.	Fre. MHz	PK dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	1061.0122	45.58	N.A.	N.A.	74.00	N.A.	54.00	V	PASS
2	1333.0666	43.60	N.A.	N.A.	74.00	N.A.	54.00	V	PASS
3	1998.1996	47.99	N.A.	N.A.	74.00	N.A.	54.00	V	PASS
4	2461.2923	53.18	N.A.	27.64	74.00	N.A.	54.00	V	PASS
5	2664.3329	50.10	N.A.	N.A.	74.00	N.A.	54.00	V	PASS
6	5233.8468	53.83	N.A.	31.29	74.00	N.A.	54.00	V	PASS



No.	Fre. MHz	PK dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	34.8505	29.59	N.A.	N.A.	N.A.	40.00	N.A.	H	PASS
2	62.5953	35.41	N.A.	N.A.	N.A.	40.00	N.A.	H	PASS
3	70.1620	34.06	N.A.	N.A.	N.A.	40.00	N.A.	H	PASS
4	186.5737	35.82	N.A.	N.A.	N.A.	43.50	N.A.	H	PASS
5	240.0260	39.09	N.A.	N.A.	N.A.	46.00	N.A.	H	PASS
6	332.2822	36.05	N.A.	N.A.	N.A.	46.00	N.A.	H	PASS



No.	Fre. MHz	PK dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	1199.0398	42.84	N.A.	N.A.	74.00	N.A.	54.00	H	PASS
2	1350.0700	43.41	N.A.	N.A.	74.00	N.A.	54.00	H	PASS
3	1997.1994	44.13	N.A.	N.A.	74.00	N.A.	54.00	H	PASS
4	2433.2867	49.16	N.A.	N.A.	74.00	N.A.	54.00	H	PASS
5	2660.3321	47.41	N.A.	N.A.	74.00	N.A.	54.00	H	PASS
6	5260.8522	44.82	N.A.	N.A.	74.00	N.A.	54.00	H	PASS



Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission Measurement

Measuring Uncertainty for a Level of Confidence of 95%(U=2Uc(y))	9kHz-150kHz	±3.3dB
	150kHz-30MHz	±2.8dB

Uncertainty of Radiated Emission Measurement

Measuring Uncertainty for a Level of Confidence of 95%(U=2Uc(y))	30MHz-200MHz	±5.06dB
	200MHz-1000MHz	±5.04dB
	1GHz-6GHz	±5.18dB
	6GHz-18GHz	±5.48dB



Annex B Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Laboratory Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory:	The FCC designation number is CN1192. Test firm registration number is 226174. (Shenzhen Morlab Communications Technology Co., Ltd.)
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4. Test Software Utilized

Model	Version Number	Producer
JS32-RE	Version 2.0.2.0	Tonscend
TS+ -[JS32-CE]	Version2.5.0.0	Tonscend

**5. Test Equipments Utilized**

Description	Model	Serial No.	Manufacturer	Cal. Date	Due. Date
Bi-Log Antenna	VULB 9163	9163-519	SCHWARZBECK	2019/5/24	2022/5/23
Horn Antenna	BBHA 9120D	01774	SCHWARZBECK	2019/7/26	2022/7/25
Horn Antenna	BBHA 9170	BBHA 9170#774	SCHWARZBECK	2019/7/26	2022/7/25
Receiver	N9038A	MY564000 93	KEYSIGHT	2021/3/9	2022/3/8
6db Attenuator	BW-N6W5+	E191001	Mini-circuits	2021/10/18	2022/10/17
Preamplifier	S020180L3203	61171/611 72	LUCIX CORP.	2021/7/15	2022/7/14
Preamplifier	S10M100L3802	46732	LUCIX CORP.	2021/7/15	2022/7/14
Receiver	ESPI	101052	R&S	2021/7/16	2022/7/15
LISN	NSLK 8127	8127449	Schwarzbeck	2021/3/9	2022/3/8
10dB Pulse Limiter	VTSD 9561-F	VTSD 9561 F-B #206	SCHWARZBECK	2021/7/21	2022/7/20

6. Ancillary Equipment Utilized

Description	Manufacturer	Model	Serial No.
PC	DELL	VOSTRO 5370	DF2DR A01 DPC
PC Adapter	DELL	LA45NM140	OKXTTW

_____ END OF REPORT _____